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### What is "[Embedded - Microcontrollers](#)"?

"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

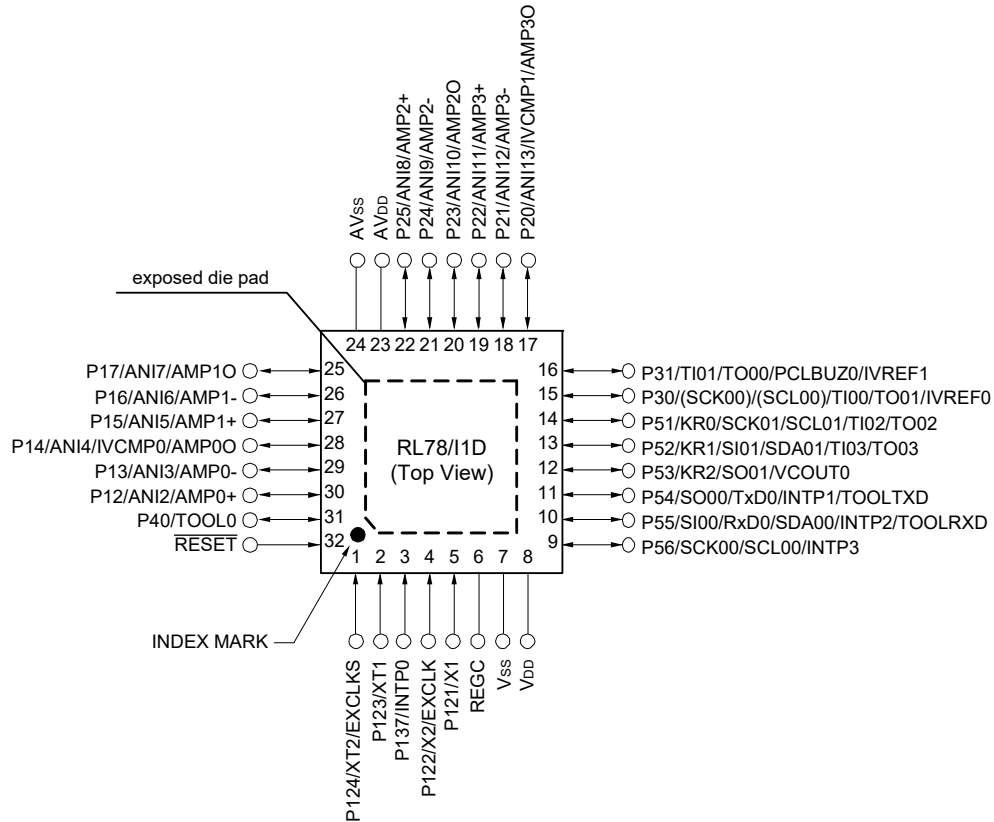
### Applications of "[Embedded - Microcontrollers](#)"

#### Details

Product Status	Active
Core Processor	RL78
Core Size	16-Bit
Speed	24MHz
Connectivity	CSI, I <sup>2</sup> C, UART/USART
Peripherals	LVD, POR, WDT
Number of I/O	21
Program Memory Size	16KB (16K x 8)
Program Memory Type	FLASH
EEPROM Size	2K x 8
RAM Size	2K x 8
Voltage - Supply (Vcc/Vdd)	1.6V ~ 3.6V
Data Converters	A/D 12x8/12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount
Package / Case	32-VFQFN Exposed Pad
Supplier Device Package	32-HVQFN (5x5)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/renesas-electronics-america/r5f117bagna-20">https://www.e-xfl.com/product-detail/renesas-electronics-america/r5f117bagna-20</a>

### 1.3.4 32-pin products

- <R> • 32-pin plastic HVQFN (5 × 5 mm, 0.5 mm pitch)



**Caution 1.** Connect the REGC pin to V<sub>ss</sub> pin via a capacitor (0.47 to 1 μF).

**Caution 2.** Make AV<sub>SS</sub> pin the same potential as V<sub>ss</sub> pin.

**Caution 3.** Make AV<sub>DD</sub> pin the same potential as V<sub>DD</sub> pin.

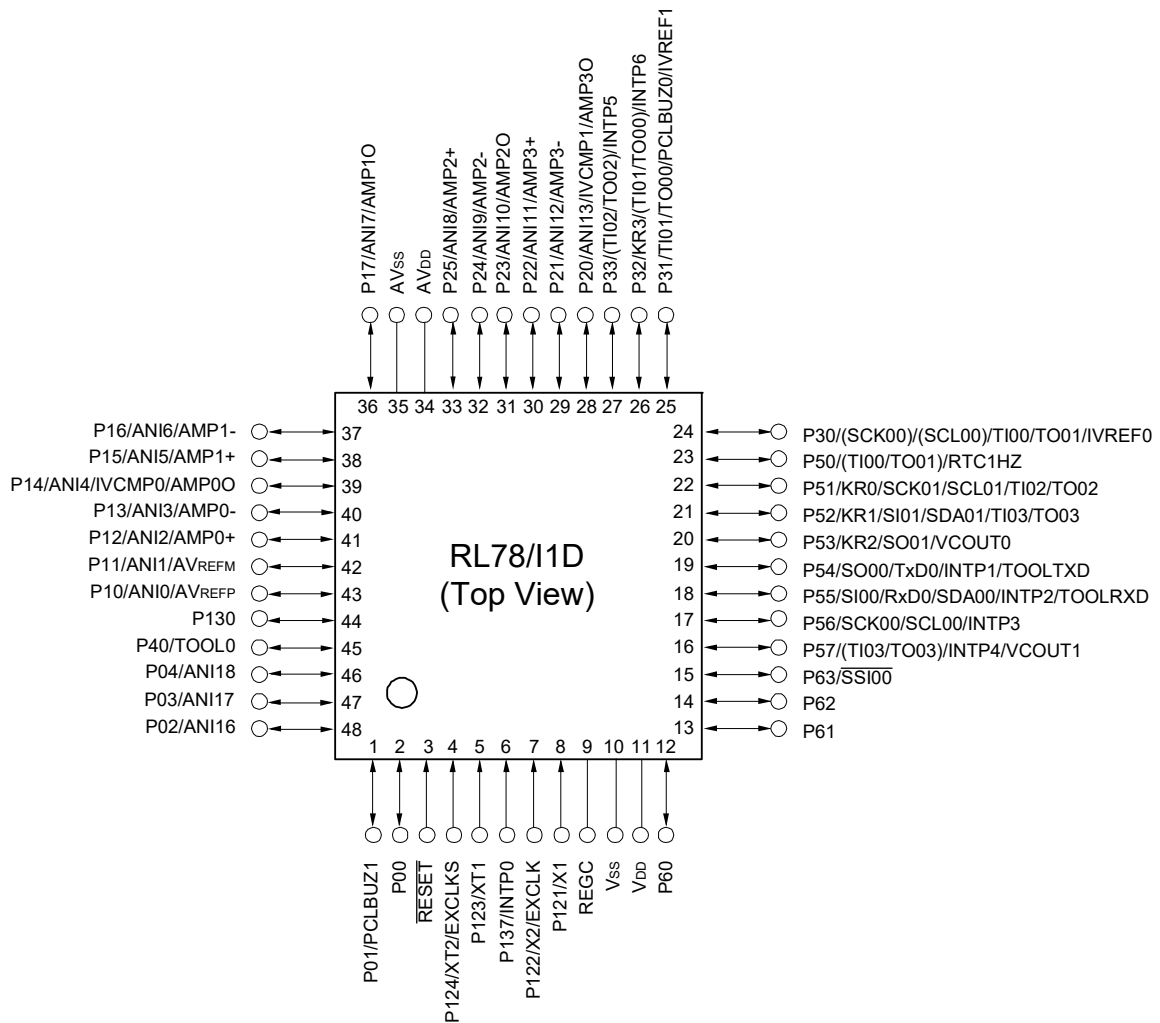
**Remark 1.** For pin identification, see 1.4 Pin Identification.

**Remark 2.** Functions in parentheses in the above figure can be assigned via settings in the peripheral I/O redirection register 0 (PIOR0).

**Remark 3.** It is recommended to connect an exposed die pad to V<sub>ss</sub>.

### 1.3.5 48-pin products

<R> • 48-pin plastic LQFP (7 × 7 mm, 0.5 mm pitch)



**Caution 1.** Connect the REGC pin to Vss pin via a capacitor (0.47 to 1 μF).

**Caution 2.** Make AVss pin the same potential as Vss pin.

**Caution 3.** Make AVDD pin the same potential as VDD pin.

**Remark 1.** For pin identification, see 1.4 Pin Identification.

**Remark 2.** Functions in parentheses in the above figure can be assigned via settings in the peripheral I/O redirection register 0 (PIOR0).

## 1.6 Outline of Functions

**Remark** This outline describes the functions at the time when Peripheral I/O redirection register 0 (PIOR0) are set to 00H.

(1/2)

Item		20-pin	24-pin	30-pin	32-pin	48-pin
		R5F1176x (x = 8, A)	R5F1177x (x = 8, A)	R5F117Ax (x = 8, A, C)	R5F117Bx (x = A, C)	R5F117Gx (x = A, C)
Code flash memory (KB)		8 to 16 KB	8 to 16 KB	8 to 32 KB	16 to 32 KB	16 to 32 KB
Data flash memory (KB)		2 KB	2 KB	2 KB	2 KB	2 KB
RAM		0.7 to 2.0 KB	0.7 to 2.0 KB	0.7 to 3.0 KB Note	2.0 to 3.0 KB Note	2.0 to 3.0 KB Note
Address space		1 MB				
<R>	Main system clock	High-speed system clock (f <sub>MX</sub> ) X1 (crystal/ceramic) oscillation, external main system clock input (EXCLK) HS (High-speed main) mode: 1 to 20 MHz (V <sub>DD</sub> = 2.7 to 3.6 V), HS (High-speed main) mode: 1 to 16 MHz (V <sub>DD</sub> = 2.4 to 3.6 V), LS (Low-speed main) mode: 1 to 8 MHz (V <sub>DD</sub> = 1.8 to 3.6 V), LV (Low-voltage main) mode: 1 to 4 MHz (V <sub>DD</sub> = 1.6 to 3.6 V), LP (Low-power main) mode: 1 MHz (V <sub>DD</sub> = 1.8 to 3.6 V)				
	High-speed on-chip oscillator clock (f <sub>IH</sub> ) Max: 24 MHz	HS (High-speed main) mode: 1 to 24 MHz (V <sub>DD</sub> = 2.7 to 3.6 V), HS (High-speed main) mode: 1 to 16 MHz (V <sub>DD</sub> = 2.4 to 3.6 V), LS (Low-speed main) mode: 1 to 8 MHz (V <sub>DD</sub> = 1.8 to 3.6 V), LV (Low-voltage main) mode: 1 to 4 MHz (V <sub>DD</sub> = 1.6 to 3.6 V), LP (Low-power main) mode: 1 MHz (V <sub>DD</sub> = 1.8 to 3.6 V)				
	Middle-speed on-chip oscillator clock (f <sub>IM</sub> ) Max: 4 MHz	HS (High-speed main) mode: 1 to 24 MHz (V <sub>DD</sub> = 2.7 to 3.6 V), HS (High-speed main) mode: 1 to 16 MHz (V <sub>DD</sub> = 2.4 to 3.6 V), LS (Low-speed main) mode: 1 to 8 MHz (V <sub>DD</sub> = 1.8 to 3.6 V), LV (Low-voltage main) mode: 1 to 4 MHz (V <sub>DD</sub> = 1.6 to 3.6 V), LP (Low-power main) mode: 1 MHz (V <sub>DD</sub> = 1.8 to 3.6 V)				
Subsystem clock	Subsystem clock oscillator (f <sub>SX</sub> , f <sub>SXR</sub> )	—		XT1 (crystal) oscillation 32.768 kHz (TYP.): V <sub>DD</sub> = 1.6 to 3.6 V		
	Low-speed on-chip oscillator clock (f <sub>IL</sub> )	15 kHz (TYP.): V <sub>DD</sub> = 1.6 to 3.6 V				
General-purpose register		8 bits × 32 registers (8 bits × 8 registers × 4 banks)				
Minimum instruction execution time		0.04167 μs (High-speed on-chip oscillator clock: f <sub>IH</sub> = 24 MHz operation)				
		0.05 μs (High-speed system clock: f <sub>MX</sub> = 20 MHz operation)				
		—		30.5 μs (Subsystem clock oscillator clock: f <sub>SX</sub> = 32.768 kHz operation)		
Instruction set		<ul style="list-style-type: none"> <li>• Data transfer (8/16 bits)</li> <li>• Adder and subtractor/logical operation (8/16 bits)</li> <li>• Multiplication (8 bits × 8 bits, 16 bits × 16 bits), Division (16 bits ÷ 16 bits, 32 bits ÷ 32 bits)</li> <li>• Multiplication and Accumulation (16 bits × 16 bits + 32 bits)</li> <li>• Rotate, barrel shift, and bit manipulation (Set, reset, test, and Boolean operation), etc.</li> </ul>				
I/O port	Total	14	18	24	26	42
	CMOS I/O	11	15	19	21	33
	CMOS input	3	3	5	5	5
	N-ch open-drain I/O (6 V tolerance)	—	—	—	—	4
Timer	16-bit timer	4 channels				
	Watchdog timer	1 channel				
	Real-time clock	1 channel				
	12-bit interval timer	1 channel				
	8/16-bit interval timer	4 channels (8 bit) / 2 channels (16 bit)				
	Timer output	2	4	3	4	4
	RTC output	—		1 channel • 1 Hz (subsystem clock generator and RTC/other clock: f <sub>SX</sub> = 32.768 kHz)		

**Note** The flash library uses RAM in self-programming and rewriting of the data flash memory. The target products and start address of the RAM areas used by the flash library are shown below.

R5F117xC (x = A, B, G): Start address FF300H

For the RAM areas used by the flash library, see **Self RAM list of Flash Self-Programming Library for RL78 Family (R20UT2944)**.

## 2. ELECTRICAL SPECIFICATIONS

- Caution 1.** The RL78 microcontrollers have an on-chip debug function, which is provided for development and evaluation. Do not use the on-chip debug function in products designated for mass production, because the guaranteed number of rewritable times of the flash memory may be exceeded when this function is used, and product reliability therefore cannot be guaranteed. Renesas Electronics is not liable for problems occurring when the on-chip debug function is used.
- Caution 2.** The pins mounted depend on the product. Refer to 2.1 Port Functions to 2.2.1 Functions for each product in the RL78/I1D User's Manual.
- Caution 3.** Please contact Renesas Electronics sales office for derating of operation under  $T_A = +85$  to  $+105^\circ\text{C}$ . Derating is the systematic reduction of load for the sake of improved reliability.
- Caution 4.** When operating temperature exceeds  $85^\circ\text{C}$ , only HS (high-speed main) mode can be used as the flash operation mode. Regulator mode should be used with the normal setting (MCSEL = 0).

&lt;R&gt;

- Note 1.** Total current flowing into V<sub>DD</sub>, including the input leakage current flowing when the level of the input pin is fixed to V<sub>DD</sub> or V<sub>SS</sub>. The MAX values include the peripheral operating current. However, these values do not include the current flowing into the A/D converter, operational amplifier, comparator, LVD circuit, I/O ports, and on-chip pull-up/pull-down resistors, and the current flowing during data flash rewrite.
- Note 2.** When the HALT instruction is executed in the flash memory.
- Note 3.** When the high-speed on-chip oscillator clock, middle-speed on-chip oscillator clock, low-speed on-chip oscillator clock, and sub clock are stopped.
- Note 4.** When the high-speed system clock, middle-speed on-chip oscillator clock, low-speed on-chip oscillator clock, and sub clock are stopped.
- Note 5.** When the high-speed system clock, middle-speed on-chip oscillator clock, low-speed on-chip oscillator clock, and high-speed on-chip oscillator clock are stopped. When RTCLPC = 1 and ultra-low-power consumption oscillation is set (AMPHS1, AMPHS0) = (1, 0). The values include the current flowing into the real-time clock. However, the values do not include the current flowing into the 12-bit interval timer and watchdog timer.
- Note 6.** When the high-speed on-chip oscillator clock, middle-speed on-chip oscillator clock, high-speed system clock, and sub clock are stopped.
- Note 7.** When the high-speed system clock, high-speed on-chip oscillator clock, low-speed on-chip oscillator clock, and sub clock are stopped.
- Remark 1.** f<sub>MX</sub>: High-speed system clock frequency (X1 clock oscillation frequency or external main system clock frequency)
- Remark 2.** f<sub>IH</sub>: High-speed on-chip oscillator clock frequency (24 MHz max.)
- Remark 3.** f<sub>IM</sub>: Middle-speed on-chip oscillator clock frequency (4 MHz max.)
- Remark 4.** f<sub>IL</sub>: Low-speed on-chip oscillator clock frequency
- Remark 5.** f<sub>SX</sub>: Sub clock frequency (XT1 clock oscillation frequency)
- Remark 6.** f<sub>SUB</sub>: Subsystem clock frequency (XT1 clock oscillation frequency or low-speed on-chip oscillator clock frequency)
- Remark 7.** Except subsystem clock operation, temperature condition of the TYP. value is T<sub>A</sub> = 25°C

## Peripheral Functions (Common to all products)

(TA = -40 to +85°C, 1.6 V ≤ AVDD = VDD ≤ 3.6 V, VSS = AVSS = 0 V)

(TA = +85 to +105°C, 2.4 V ≤ AVDD = VDD ≤ 3.6 V, VSS = AVSS = 0 V)

(1/2)

Parameter	Symbol	Conditions		MIN.	TYP.	MAX.	Unit
Low-speed on-chip oscillator operating current	IFIL Note 1				0.20		μA
RTC operating current	IRTC Notes 1, 2, 3	fsx = 32.768 kHz			0.02		μA
12-bit interval timer operating current	ITMKA Notes 1, 2, 4	fsx = 32.768 kHz			0.04		μA
8-bit interval timer operating current	ITMT Notes 1, 9	fsx = 32.768 kHz fMAIN stopped (per unit)	8-bit counter mode × 2-channel operation		0.12		μA
			16-bit counter mode operation		0.10		μA
Watchdog timer operating current	IWDT Notes 1, 2, 5	fil = 15 kHz			0.22		μA
A/D converter operating current	IADC Notes 6, 10	During maximum-speed conversion	AVDD = 3.0 V		420	720	μA
AVREF(+) current	IAREF Note 11	AVREFP = 3.0 V, ADREFP1 = 0, ADREFP0 = 1			14.0	25.0	μA
Internal reference voltage (1.45 V) current	IADREF Notes 1, 12				85.0		μA
Temperature sensor operating current	ITMPS Note 1				85.0		μA
Comparator operating current	ICMP Notes 8, 10	AVDD = 3.6 V, Regulator output voltage = 2.1 V	Comparator high-speed mode Window mode		12.5		μA
			Comparator low-speed mode Window mode		3.0		
			Comparator high-speed mode Standard mode		6.5		
			Comparator low-speed mode Standard mode		1.7		
		AVDD = 3.6 V, Regulator output voltage = 1.8 V	Comparator high-speed mode Window mode		8.0		
			Comparator low-speed mode Window mode		2.2		
			Comparator high-speed mode Standard mode		4.0		
			Comparator low-speed mode Standard mode		1.3		
Operational amplifier operating current	IAMP Notes 10, 13	Low-power consumption mode	One operational amplifier unit operates Note 14		2.5	4.0	μA
			Two operational amplifier units operate Note 14		4.5	8.0	
			Three operational amplifier units operate Note 14		6.5	11.0	
			Four operational amplifier units operate Note 14		8.5	14.0	
		High-speed mode	One operational amplifier unit operates Note 14		140	220	
			Two operational amplifier units operate Note 14		280	410	
			Three operational amplifier units operate Note 14		420	600	
			Four operational amplifier units operate Note 14		560	780	
LVD operating current	ILVD Notes 1, 7				0.10		μA

(Notes and Remarks are listed on the next page.)

## (4) During communication at same potential (CSI mode) (slave mode, SCKp... external clock input)

(TA = -40 to +85°C, 1.6 V ≤ AVDD = VDD ≤ 3.6 V, VSS = AVSS = 0 V)

(1/2)

Parameter	Symbol	Conditions		HS (high-speed main) Mode		LS (low-speed main) Mode		LP (Low-power main) mode		LV (low-voltage main) Mode		Unit
				MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
SCKp cycle time Note 5	tkcy2	2.7 V ≤ VDD ≤ 3.6 V	fMCK > 16 MHz	8/fMCK	—	—	—	—	—	—	ns	
			fMCK ≤ 16 MHz	6/fMCK	6/fMCK	6/fMCK	6/fMCK	6/fMCK				
		2.4 V ≤ VDD ≤ 3.6 V		6/fMCK and 500	6/fMCK	6/fMCK	6/fMCK	6/fMCK	6/fMCK			
		1.8 V ≤ VDD ≤ 3.6 V		—	6/fMCK	6/fMCK	6/fMCK	6/fMCK	6/fMCK			
		1.7 V ≤ VDD ≤ 3.6 V		—	—	—	—	—	—			
		1.6 V ≤ VDD ≤ 3.6 V		—	—	—	—	—	—			
SCKp high-/low-level width	tkH2, tkL2	2.7 V ≤ VDD ≤ 3.6 V		tkcy2/2 - 8	tkcy2/2 - 8	tkcy2/2 - 8	tkcy2/2 - 8	tkcy2/2 - 8	tkcy2/2 - 8	ns		
		2.4 V ≤ VDD ≤ 3.6 V		tkcy2/2 - 18	tkcy2/2 - 18	tkcy2/2 - 18	tkcy2/2 - 18	tkcy2/2 - 18	tkcy2/2 - 18			
		1.8 V ≤ VDD ≤ 3.6 V		—	—	—	—	—	—			
		1.7 V ≤ VDD ≤ 3.6 V		—	—	—	—	tkcy2/2 - 66	tkcy2/2 - 66			
		1.6 V ≤ VDD ≤ 3.6 V		—	—	—	—	—	—			
Slp setup time (to SCKp↓) Note 1	tsik2	2.7 V ≤ VDD ≤ 3.6 V		1/fMCK + 20	1/fMCK + 30	1/fMCK + 30	1/fMCK + 30	1/fMCK + 30	1/fMCK + 30	ns		
		2.4 V ≤ VDD ≤ 3.6 V		1/fMCK + 30	—	—	—	—	—			
		1.8 V ≤ VDD ≤ 3.6 V		—	—	—	—	—	—			
		1.7 V ≤ VDD ≤ 3.6 V		—	—	—	—	1/fMCK + 40	1/fMCK + 40			
		1.6 V ≤ VDD ≤ 3.6 V		—	—	—	—	—	—			
Slp hold time (from SCKp↑) Note 2	tkSiz	2.4 V ≤ VDD ≤ 3.6 V		1/fMCK + 31	1/fMCK + 31	1/fMCK + 31	1/fMCK + 31	1/fMCK + 31	1/fMCK + 31	ns		
		1.8 V ≤ VDD ≤ 3.6 V		—	—	—	—	—	—			
		1.7 V ≤ VDD ≤ 3.6 V		—	—	—	—	1/fMCK + 250	1/fMCK + 250			
		1.6 V ≤ VDD ≤ 3.6 V		—	—	—	—	—	—			
Delay time from SCKp↓ to SOp output Note 3	tkso2	C = 30 pF Note 4	2.7 V ≤ VDD ≤ 3.6 V	2/fMCK + 44	2/fMCK + 110	2/fMCK + 110	2/fMCK + 110	2/fMCK + 110	2/fMCK + 110	ns		
			2.4 V ≤ VDD ≤ 3.6 V	2/fMCK + 75	—	—	—	—	—			
			1.8 V ≤ VDD ≤ 3.6 V	—	—	—	—	—	—			
			1.7 V ≤ VDD ≤ 3.6 V	—	—	—	—	2/fMCK + 220	2/fMCK + 220			
			1.6 V ≤ VDD ≤ 3.6 V	—	—	—	—	—	—			

**Note 1.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The Slp setup time becomes “to SCKp↓” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 2.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The Slp hold time becomes “from SCKp↓” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 3.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The delay time to SOp output becomes “from SCKp↑” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 4.** C is the load capacitance of the SOp output lines.

**Note 5.** The maximum transfer rate when using the SNOOZE mode is 1 Mbps.

**Caution** Select the normal input buffer for the Slp pin and the normal output mode for the SOp pin by using port input mode register g (PIMg) and port output mode register g (POMg).

**Remark 1.** p: CSI number (p = 00), m: Unit number (m = 0), n: Channel number (n = 0), g: PIM and POM numbers (g = 5)

**Remark 2.** fMCK: Serial array unit operation clock frequency  
(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number (mn = 00, 01))



**(4) During communication at same potential (CSI mode) (slave mode, SCKp... external clock input)****(TA = +85 to +105°C, 2.4 V ≤ AVDD = VDD ≤ 3.6 V, VSS = AVSS = 0 V)****(1/2)**

Parameter	Symbol	Conditions	HS (high-speed main) Mode		Unit	
			MIN.	MAX.		
SCKp cycle time Note 5	tkcy2	2.7 V ≤ VDD < 3.6 V	fMCK > 16 MHz	16/fMCK	ns	
			fMCK ≤ 16 MHz	12/fMCK	ns	
		2.4 V ≤ VDD < 2.7 V	12/fMCK and 1000	ns		
SCKp high-/low-level width	tkH2, tkL2	2.7 V ≤ VDD ≤ 3.6 V	tkcy2/2 - 16		ns	
		2.4 V ≤ VDD < 2.7 V	tkcy2/2 - 36		ns	
Slp setup time (to SCKp↑) Note 1	tsIK2	2.7 V ≤ VDD ≤ 3.6 V	1/fMCK + 40		ns	
		2.4 V ≤ VDD < 2.7 V	1/fMCK + 60		ns	
Slp hold time (from SCKp↑) Note 2	tkS12		1/fMCK + 62		ns	
Delay time from SCKp↓ to SOp output Note 3	tkSO2	C = 30 pF Note 4	2.7 V ≤ VDD ≤ 3.6 V		2/fMCK + 66	ns
			2.4 V ≤ VDD < 2.7 V		2/fMCK + 113	ns

**Note 1.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The Slp setup time becomes “to SCKp↓” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 2.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The Slp hold time becomes “from SCKp↓” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 3.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The delay time to SOp output becomes “from SCKp↑” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 4.** C is the load capacitance of the SOp output lines.

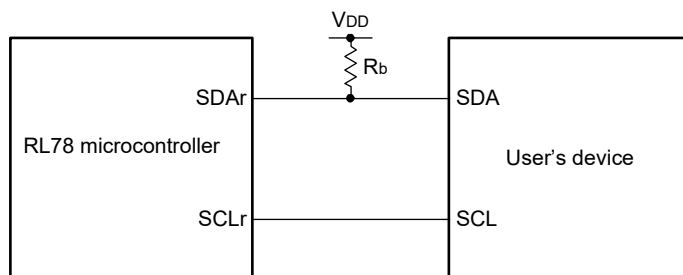
**Note 5.** The maximum transfer rate when using the SNOOZE mode is 1 Mbps.

**Caution** Select the normal input buffer for the Slp pin and the normal output mode for the SOp pin by using port input mode register g (PIMg) and port output mode register g (POMg).

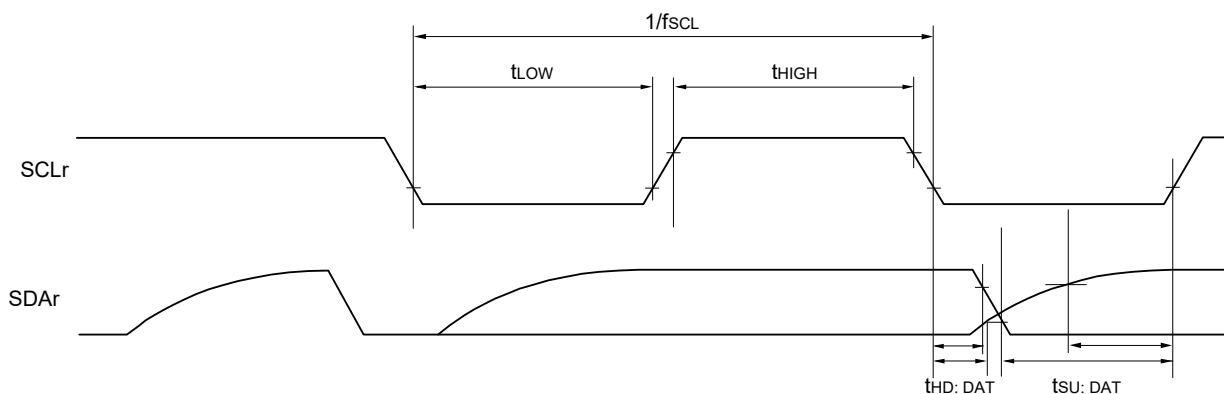
**Remark 1.** p: CSI number (p = 00), m: Unit number (m = 0), n: Channel number (n = 0), g: PIM and POM numbers (g = 5)

**Remark 2.** fMCK: Serial array unit operation clock frequency  
(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number (mn = 00, 01))

**Simplified I<sup>2</sup>C mode connection diagram (during communication at same potential)**

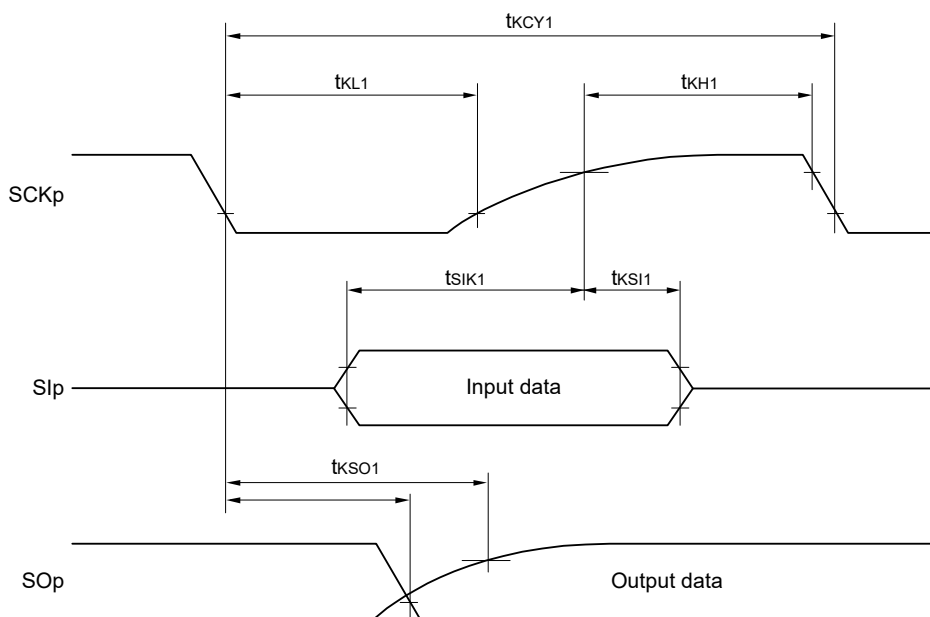


**Simplified I<sup>2</sup>C mode serial transfer timing (during communication at same potential)**

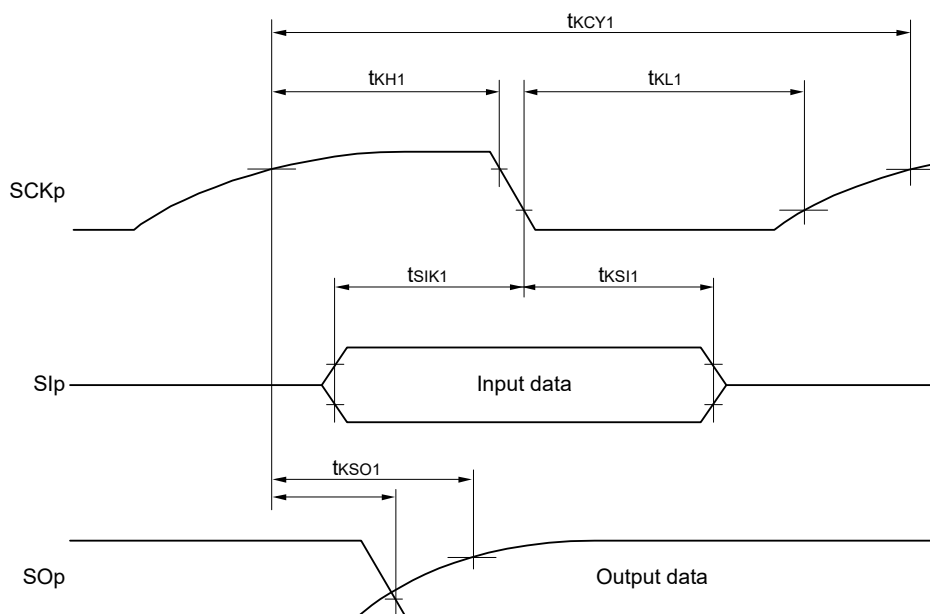


- Remark 1.**  $R_b[\Omega]$ : Communication line (SDAr) pull-up resistance,  $C_b[F]$ : Communication line (SDAr, SCLr) load capacitance
- Remark 2.** r: IIC number (r = 00, 01), g: PIM number (g = 5), h: POM number (h = 5)
- Remark 3.**  $f_{mck}$ : Serial array unit operation clock frequency  
 (Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number (m = 0), n: Channel number (n = 0, 1), mn = 00, 01)

**CSI mode serial transfer timing (master mode) (during communication at different potential)  
(When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1.)**



**CSI mode serial transfer timing (master mode) (during communication at different potential)  
(When DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.)**



**Remark** p: CSI number (p = 00, 01), m: Unit number (m = 0), n: Channel number (n = 0, 1), g: PIM and POM numbers (g = 5)

**(8) Communication at different potential (1.8 V, 2.5 V) (CSI mode) (master mode, SCKp... internal clock output)****(TA = +85 to 105°C, 2.4 V ≤ AVDD = VDD ≤ 3.6 V, VSS = AVSS = 0 V)****(2/2)**

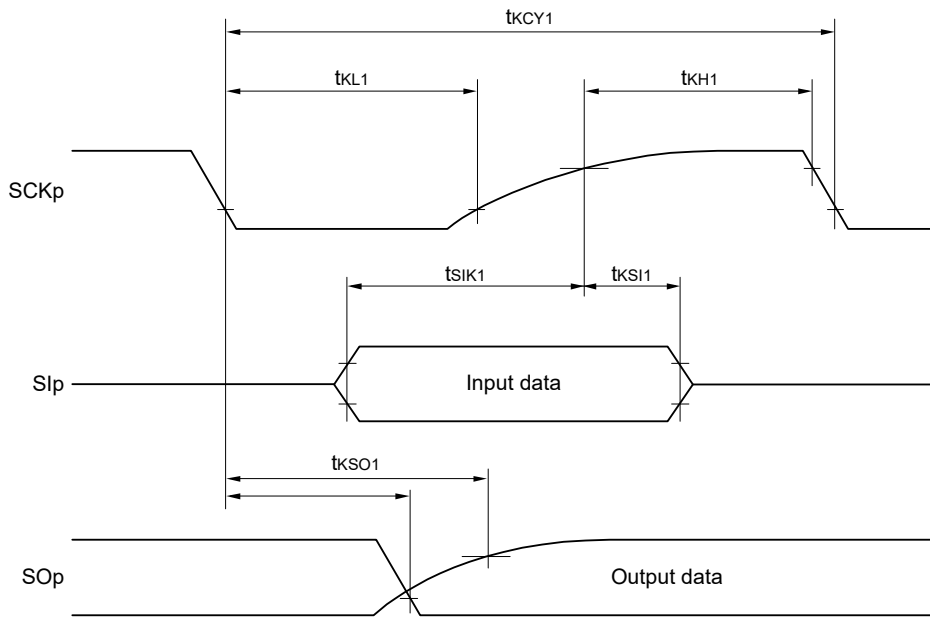
Parameter	Symbol	Conditions	HS (high-speed main) Mode		Unit
			MIN.	MAX.	
Slp setup time (to SCKp↑) <sup>Note 1</sup>	tSIK1	2.7 V ≤ VDD ≤ 3.6 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 30 pF, Rb = 2.7 kΩ	354		ns
		2.4 V ≤ VDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V <sup>Note 3</sup> , Cb = 30 pF, Rb = 5.5 kΩ	958		ns
Slp hold time (from SCKp↑) <sup>Note 1</sup>	tKS11	2.7 V ≤ VDD ≤ 3.6 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 30 pF, Rb = 2.7 kΩ	38		ns
		2.4 V ≤ VDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V <sup>Note 3</sup> , Cb = 30 pF, Rb = 5.5 kΩ	38		ns
Delay time from SCKp↓ to SOp output <sup>Note 1</sup>	tKS01	2.7 V ≤ VDD ≤ 3.6 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 30 pF, Rb = 2.7 kΩ		390	ns
		2.4 V ≤ VDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V <sup>Note 3</sup> , Cb = 30 pF, Rb = 5.5 kΩ		966	ns
Slp setup time (to SCKp↓) <sup>Note 2</sup>	tSIK1	2.7 V ≤ VDD ≤ 3.6 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 30 pF, Rb = 2.7 kΩ	88		ns
		2.4 V ≤ VDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V <sup>Note 3</sup> , Cb = 30 pF, Rb = 5.5 kΩ	220		ns
Slp hold time (from SCKp↓) <sup>Note 2</sup>	tKS11	2.7 V ≤ VDD ≤ 3.6 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 30 pF, Rb = 2.7 kΩ	38		ns
		2.4 V ≤ VDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V <sup>Note 3</sup> , Cb = 30 pF, Rb = 5.5 kΩ	38		ns
Delay time from SCKp↑ to SOp output <sup>Note 2</sup>	tKS01	2.7 V ≤ VDD ≤ 3.6 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 30 pF, Rb = 2.7 kΩ		50	ns
		2.4 V ≤ VDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V <sup>Note 3</sup> , Cb = 30 pF, Rb = 5.5 kΩ		50	ns

**Note 1.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1.**Note 2.** When DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.**Note 3.** Use it with VDD ≥ Vb.

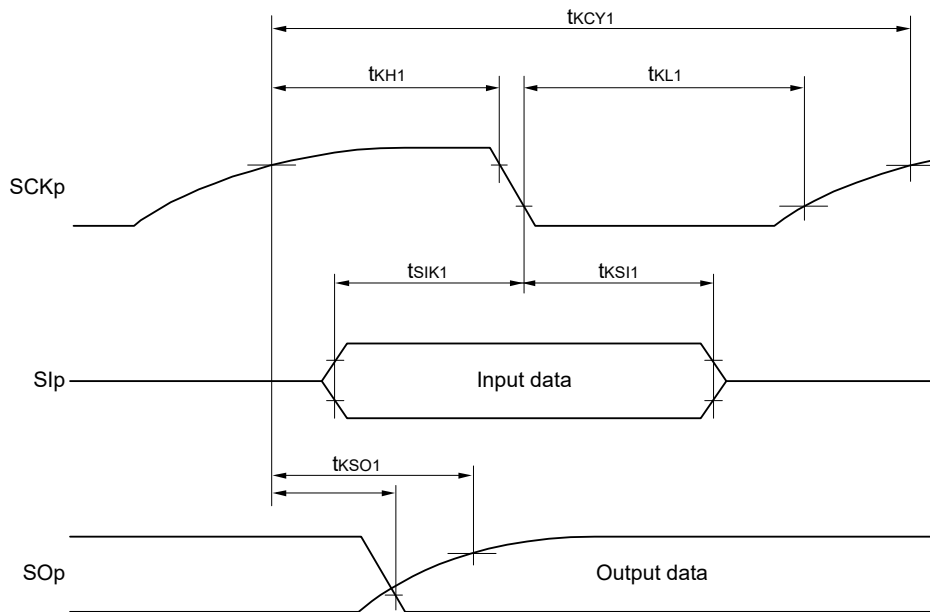
**Caution** Select the TTL input buffer for the Slp pin and the N-ch open drain output (VDD tolerance) mode for the SOp pin and SCKp pin by using port input mode register g (PIMg) and port output mode register g (POMg). For VIH and VIL, see the DC characteristics with TTL input buffer selected.

(Remarks are listed on the next page.)

**CSI mode serial transfer timing (master mode) (during communication at different potential)  
(When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1.)**



**CSI mode serial transfer timing (master mode) (during communication at different potential)  
(When DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.)**



**Remark** p: CSI number (p = 00, 01), m: Unit number (m = 0), n: Channel number (n = 0, 1), g: PIM and POM numbers (g = 5)

**(10) Communication at different potential (1.8 V, 2.5 V) (simplified I<sup>2</sup>C mode)****(T<sub>A</sub> = +85 to 105°C, 2.4 V ≤ AV<sub>DD</sub> = V<sub>DD</sub> ≤ 3.6 V, V<sub>SS</sub> = AV<sub>SS</sub> = 0 V)**

Parameter	Symbol	Conditions	HS (high-speed main) Mode		Unit
			MIN.	MAX.	
SCLr clock frequency	f <sub>SCL</sub>	2.7 V ≤ V <sub>DD</sub> ≤ 3.6 V, 2.3 V ≤ V <sub>b</sub> ≤ 2.7 V, C <sub>b</sub> = 50 pF, R <sub>b</sub> = 2.7 kΩ		400 Note 1	kHz
		2.7 V ≤ V <sub>DD</sub> ≤ 3.6 V, 2.3 V ≤ V <sub>b</sub> ≤ 2.7 V, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 2.7 kΩ		100 Note 1	kHz
		2.4 V ≤ V <sub>DD</sub> < 3.3 V, 1.6 V ≤ V <sub>b</sub> ≤ 2.0 V Note 2, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 5.5 kΩ		100 Note 1	kHz
Hold time when SCLr = "L"	t <sub>LOW</sub>	2.7 V ≤ V <sub>DD</sub> ≤ 3.6 V, 2.3 V ≤ V <sub>b</sub> ≤ 2.7 V, C <sub>b</sub> = 50 pF, R <sub>b</sub> = 2.7 kΩ	1200		ns
		2.7 V ≤ V <sub>DD</sub> ≤ 3.6 V, 2.3 V ≤ V <sub>b</sub> ≤ 2.7 V, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 2.7 kΩ	4600		ns
		2.4 V ≤ V <sub>DD</sub> < 3.3 V, 1.6 V ≤ V <sub>b</sub> ≤ 2.0 V Note 2, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 5.5 kΩ	4650		ns
Hold time when SCLr = "H"	t <sub>HIGH</sub>	2.7 V ≤ V <sub>DD</sub> ≤ 3.6 V, 2.3 V ≤ V <sub>b</sub> ≤ 2.7 V, C <sub>b</sub> = 50 pF, R <sub>b</sub> = 2.7 kΩ	500		ns
		2.7 V ≤ V <sub>DD</sub> ≤ 3.6 V, 2.3 V ≤ V <sub>b</sub> ≤ 2.7 V, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 2.7 kΩ	2400		ns
		2.4 V ≤ V <sub>DD</sub> < 3.3 V, 1.6 V ≤ V <sub>b</sub> ≤ 2.0 V Note 2, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 5.5 kΩ	1830		ns
Data setup time (reception)	t <sub>SU-DAT</sub>	2.7 V ≤ V <sub>DD</sub> ≤ 3.6 V, 2.3 V ≤ V <sub>b</sub> ≤ 2.7 V, C <sub>b</sub> = 50 pF, R <sub>b</sub> = 2.7 kΩ	1/f <sub>MCK</sub> + 340 Note 3		ns
		2.7 V ≤ V <sub>DD</sub> ≤ 3.6 V, 2.3 V ≤ V <sub>b</sub> ≤ 2.7 V, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 2.7 kΩ	1/f <sub>MCK</sub> + 760 Note 3		ns
		2.4 V ≤ V <sub>DD</sub> < 3.3 V, 1.6 V ≤ V <sub>b</sub> ≤ 2.0 V Note 2, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 5.5 kΩ	1/f <sub>MCK</sub> + 570 Note 3		ns
Data hold time (transmission)	t <sub>HD-DAT</sub>	2.7 V ≤ V <sub>DD</sub> ≤ 3.6 V, 2.3 V ≤ V <sub>b</sub> ≤ 2.7 V, C <sub>b</sub> = 50 pF, R <sub>b</sub> = 2.7 kΩ	0	770	ns
		2.7 V ≤ V <sub>DD</sub> ≤ 3.6 V, 2.3 V ≤ V <sub>b</sub> ≤ 2.7 V, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 2.7 kΩ	0	1420	ns
		2.4 V ≤ V <sub>DD</sub> < 3.3 V, 1.6 V ≤ V <sub>b</sub> ≤ 2.0 V Note 2, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 5.5 kΩ	0	1215	ns

**Note 1.** The value must also be equal to or less than f<sub>MCK</sub>/4.**Note 2.** Use it with V<sub>DD</sub> ≥ V<sub>b</sub>.**Note 3.** Set the f<sub>MCK</sub> value to keep the hold time of SCLr = "L" and SCLr = "H".

**Caution** Select the TTL input buffer and the N-ch open drain output (V<sub>DD</sub> tolerance) mode for the SDAr pin and the N-ch open drain output (V<sub>DD</sub> tolerance) mode for the SCLr pin by using port input mode register g (PIMg) and port output mode register g (POMg). For V<sub>IH</sub> and V<sub>IL</sub>, see the DC characteristics with TTL input buffer selected.

(Remarks are listed on the next page.)

## 2.6 Analog Characteristics

### 2.6.1 A/D converter characteristics

#### Classification of A/D converter characteristics

Reference Voltage Input Channel	Reference voltage (+) = $AV_{REFP}$ Reference voltage (-) = $AV_{REFM}$	Reference voltage (+) = $AV_{DD}$ Reference voltage (-) = $AV_{SS}$	Reference voltage (+) = Internal reference voltage Reference voltage (-) = $AV_{SS}$
High-accuracy channel; ANI0 to ANI13 (input buffer power supply: $AV_{DD}$ )	Refer to 2.6.1 (1). Refer to 2.6.1 (7).	Refer to 2.6.1 (2). Refer to 2.6.1 (7).	Refer to 2.6.1 (5). Refer to 2.6.1 (10).
Standard channel; ANI16 to ANI18 (input buffer power supply: $V_{DD}$ )	Refer to 2.6.1 (3). Refer to 2.6.1 (8).	Refer to 2.6.1 (4). Refer to 2.6.1 (9).	
Internal reference voltage, Temperature sensor output voltage	Refer to 2.6.1 (3). Refer to 2.6.1 (8).	Refer to 2.6.1 (4). Refer to 2.6.1 (9).	—

(1) When reference voltage (+) =  $AV_{REFP}/ANI0$  ( $ADREFP1 = 0$ ,  $ADREFP0 = 1$ ), reference voltage (-) =  $AV_{REFM}/ANI1$  ( $ADREFM = 1$ ), conversion target: ANI2 to ANI13

( $T_A = -40$  to  $+85^\circ\text{C}$ ,  $1.6\text{ V} \leq AV_{REFP} \leq AV_{DD} = V_{DD} \leq 3.6\text{ V}$ ,  $V_{SS} = 0\text{ V}$ ,  $AV_{SS} = 0\text{ V}$ , Reference voltage (+) =  $AV_{REFP}$ , Reference voltage (-) =  $AV_{REFM} = 0\text{ V}$ )

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Resolution	RES	$2.4\text{ V} \leq AV_{REFP} \leq AV_{DD} \leq 3.6\text{ V}$	8		12	bit
		$1.8\text{ V} \leq AV_{REFP} \leq AV_{DD} \leq 3.6\text{ V}$	8		10 Note 1	
		$1.6\text{ V} \leq AV_{REFP} \leq AV_{DD} \leq 3.6\text{ V}$	8 Note 2			
Overall error Note 3	AINL	12-bit resolution	$2.4\text{ V} \leq AV_{REFP} \leq AV_{DD} \leq 3.6\text{ V}$		$\pm 6.0$	LSB
		10-bit resolution	$1.8\text{ V} \leq AV_{REFP} \leq AV_{DD} \leq 3.6\text{ V}$		$\pm 5.0$	
		8-bit resolution	$1.6\text{ V} \leq AV_{REFP} \leq AV_{DD} \leq 3.6\text{ V}$		$\pm 2.5$	
Conversion time	tCONV	ADTYP = 0, 12-bit resolution	$2.4\text{ V} \leq AV_{REFP} \leq AV_{DD} \leq 3.6\text{ V}$	3.375		$\mu\text{s}$
		ADTYP = 0, 10-bit resolution Note 1	$1.8\text{ V} \leq AV_{REFP} \leq AV_{DD} \leq 3.6\text{ V}$	6.75		
		ADTYP = 0, 8-bit resolution Note 2	$1.6\text{ V} \leq AV_{REFP} \leq AV_{DD} \leq 3.6\text{ V}$	13.5		
		ADTYP = 1, 8-bit resolution	$2.4\text{ V} \leq AV_{REFP} \leq AV_{DD} \leq 3.6\text{ V}$	2.5625		
			$1.8\text{ V} \leq AV_{REFP} \leq AV_{DD} \leq 3.6\text{ V}$	5.125		
Zero-scale error Note 3	Ezs	12-bit resolution	$2.4\text{ V} \leq AV_{REFP} \leq AV_{DD} \leq 3.6\text{ V}$		$\pm 4.5$	LSB
		10-bit resolution	$1.8\text{ V} \leq AV_{REFP} \leq AV_{DD} \leq 3.6\text{ V}$		$\pm 4.5$	
		8-bit resolution	$1.6\text{ V} \leq AV_{REFP} \leq AV_{DD} \leq 3.6\text{ V}$		$\pm 2.0$	
Full-scale error Note 3	EFS	12-bit resolution	$2.4\text{ V} \leq AV_{REFP} \leq AV_{DD} \leq 3.6\text{ V}$		$\pm 4.5$	LSB
		10-bit resolution	$1.8\text{ V} \leq AV_{REFP} \leq AV_{DD} \leq 3.6\text{ V}$		$\pm 4.5$	
		8-bit resolution	$1.6\text{ V} \leq AV_{REFP} \leq AV_{DD} \leq 3.6\text{ V}$		$\pm 2.0$	
Integral linearity error Note 3	ILE	12-bit resolution	$2.4\text{ V} \leq AV_{REFP} \leq AV_{DD} \leq 3.6\text{ V}$		$\pm 2.0$	LSB
		10-bit resolution	$1.8\text{ V} \leq AV_{REFP} \leq AV_{DD} \leq 3.6\text{ V}$		$\pm 1.5$	
		8-bit resolution	$1.6\text{ V} \leq AV_{REFP} \leq AV_{DD} \leq 3.6\text{ V}$		$\pm 1.0$	
Differential linearity error Note 3	DLE	12-bit resolution	$2.4\text{ V} \leq AV_{REFP} \leq AV_{DD} \leq 3.6\text{ V}$		$\pm 1.5$	LSB
		10-bit resolution	$1.8\text{ V} \leq AV_{REFP} \leq AV_{DD} \leq 3.6\text{ V}$		$\pm 1.5$	
		8-bit resolution	$1.6\text{ V} \leq AV_{REFP} \leq AV_{DD} \leq 3.6\text{ V}$		$\pm 1.0$	
Analog input voltage	VAIN		0		$AV_{REFP}$	V

**Note 1.** Cannot be used for lower 2 bit of ADCR register

**Note 2.** Cannot be used for lower 4 bit of ADCR register

**Note 3.** Excludes quantization error ( $\pm 1/2$  LSB).

**Caution** Always use  $AV_{DD}$  pin with the same potential as the  $V_{DD}$  pin.



(7) When reference voltage (+) = AVDD (ADREFP1 = 0, ADREFP0 = 0), reference voltage (-) = AVSS (ADREFM = 0), conversion target: ANI0 to ANI13

(TA = +85 to +105°C, 2.4 V ≤ AVDD = VDD ≤ 3.6 V, VSS = 0 V, AVSS = 0 V, Reference voltage (+) = AVDD, Reference voltage (-) = AVSS = 0 V)

Parameter	Symbol	Conditions		MIN.	TYP.	MAX.	Unit
Resolution	RES		2.4 V ≤ AVDD ≤ 3.6 V	8		12	bit
Overall error <sup>Note</sup>	AINL	12-bit resolution	2.4 V ≤ AVDD ≤ 3.6 V			±7.5	LSB
Conversion time	tCONV	ADTYP = 0, 12-bit resolution	2.4 V ≤ AVDD ≤ 3.6 V	3.375			μs
Zero-scale error <sup>Note</sup>	Ezs	12-bit resolution	2.4 V ≤ AVDD ≤ 3.6 V			±6.0	LSB
Full-scale error <sup>Note</sup>	EFS	12-bit resolution	2.4 V ≤ AVDD ≤ 3.6 V			±6.0	LSB
Integral linearity error <sup>Note</sup>	ILE	12-bit resolution	2.4 V ≤ AVDD ≤ 3.6 V			±3.0	LSB
Differential linearity error <sup>Note</sup>	DLE	12-bit resolution	2.4 V ≤ AVDD ≤ 3.6 V			±2.0	LSB
Analog input voltage	VAIN			0		AVDD	V

**Note** Excludes quantization error (±1/2 LSB).

**Caution** Always use AVDD pin with the same potential as the VDD pin.

## 2.6.4 Operational amplifier characteristics

( $T_A = -40$  to  $+85^\circ\text{C}$ ,  $1.8\text{ V} \leq AV_{DD} = V_{DD} \leq 3.6\text{ V}$ ,  $V_{SS} = AV_{SS} = 0\text{ V}$ )

( $T_A = +85$  to  $+105^\circ\text{C}$ ,  $2.4\text{ V} \leq AV_{DD} = V_{DD} \leq 3.6\text{ V}$ ,  $V_{SS} = AV_{SS} = 0\text{ V}$ )

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Common mode input range	Vicm1	Low-power consumption mode	0.2		$AV_{DD} - 0.5$	V
	Vicm2	High-speed mode	0.3		$AV_{DD} - 0.6$	V
Output voltage range	Vo1	Low-power consumption mode	0.1		$AV_{DD} - 0.1$	V
	Vo2	High-speed mode	0.1		$AV_{DD} - 0.1$	V
Input offset voltage	Vioff		-10		10	mV
Open gain	Av		60	120		dB
Gain-bandwidth (GB) product	GBW1	Low-power consumption mode		0.04		MHz
	GBW2	High-speed mode		1.7		MHz
Phase margin	PM	CL = 20 pF	50			deg
Gain margin	GM	CL = 20 pF	10			dB
Equivalent input noise	Vnoise1	f = 1 kHz	Low-power consumption mode	230		nV/ $\sqrt{\text{Hz}}$
	Vnoise2	f = 10 kHz		200		nV/ $\sqrt{\text{Hz}}$
	Vnoise3	f = 1 kHz	High-speed mode	90		nV/ $\sqrt{\text{Hz}}$
	Vnoise4	f = 2 kHz		70		nV/ $\sqrt{\text{Hz}}$
Power supply reduction ratio	PSRR			90		dB
Common mode signal reduction ratio	CMRR			90		dB
Operation stabilization wait time	Tstd1	CL = 20 pF Only operational amplifier is activated <sup>Note</sup>	Low-power consumption mode	650		$\mu\text{s}$
	Tstd2		High-speed mode	13		$\mu\text{s}$
	Tstd3	CL = 20 pF Operational amplifier and reference current circuit are activated simultaneously	Low-power consumption mode	650		$\mu\text{s}$
	Tstd4		High-speed mode	13		$\mu\text{s}$
Settling time	Tset1	CL = 20 pF	Low-power consumption mode		750	$\mu\text{s}$
	Tset2		High-speed mode		13	$\mu\text{s}$
Slew rate	Tslew1	CL = 20 pF	Low-power consumption mode	0.02		V/ $\mu\text{s}$
	Tslew2		High-speed mode	1.1		V/ $\mu\text{s}$
Load current	Iload1	Low-power consumption mode	-100		100	$\mu\text{A}$
	Iload2	High-speed mode	-100		100	$\mu\text{A}$
Load capacitance	CL				20	pF

**Note** When the operational amplifier reference current circuit is activated in advance.

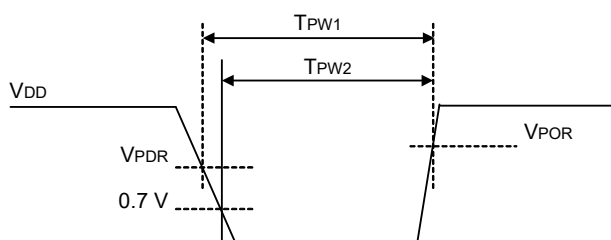
### 2.6.5 POR circuit characteristics

(TA = -40 to +105°C, Vss = AVss = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit	
Detection voltage	VPOR	Power supply rise time	TA = -40 to +85°C	1.47	1.51	1.55	V
			TA = +85 to +105°C	1.45	1.51	1.57	V
	VPDR	Power supply fall time <sup>Note 1</sup>	TA = -40 to +85°C	1.46	1.50	1.54	V
			TA = +85 to +105°C	1.44	1.50	1.56	V
Minimum pulse width <sup>Note 2</sup>	TPW1	Other than STOP/SUB HALT/SUB RUN	TA = +40 to +105°C	300			μs
	TPW2	STOP/SUB HALT/SUB RUN	TA = +40 to +105°C	300			μs

**Note 1.** However, when the operating voltage falls while the LVD is off, enter STOP mode, or enable the reset status using the external reset pin before the voltage falls below the operating voltage range shown in 2.4 AC Characteristics.

**Note 2.** Minimum time required for a POR reset when VDD exceeds below VPDR. This is also the minimum time required for a POR reset from when VDD exceeds below 0.7 V to when VDD exceeds VPOR while STOP mode is entered or the main system clock is stopped through setting bit 0 (HIOSTOP) and bit 7 (MSTOP) in the clock operation status control register (CSC).



### 2.9 Dedicated Flash Memory Programmer Communication (UART)

(TA = -40 to +85°C, 1.8 V ≤ AVDD = VDD ≤ 3.6 V, VSS = AVSS = 0 V)

(TA = +85 to +105°C, 2.4 V ≤ AVDD = VDD ≤ 3.6 V, VSS = AVSS = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Transfer rate		During serial programming	115,200		1,000,000	bps

### 2.10 Timing of Entry to Flash Memory Programming Modes

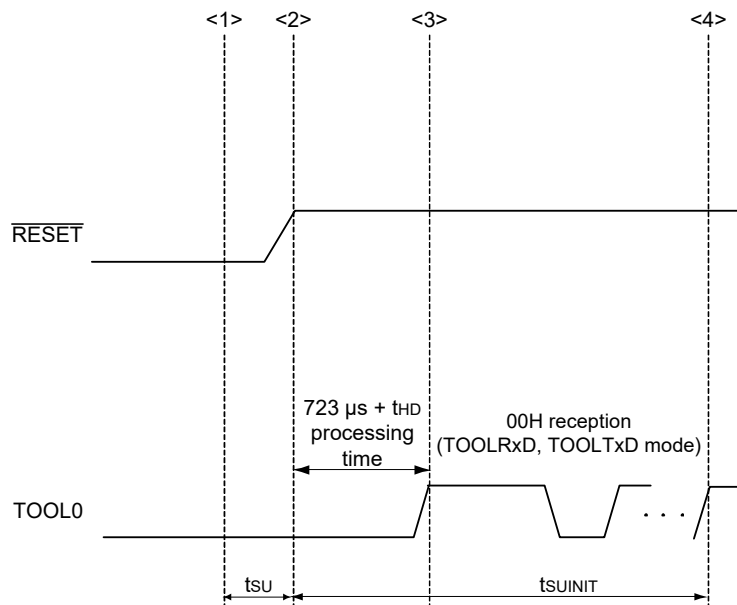
(TA = -40 to +85°C, 1.8 V ≤ AVDD = VDD ≤ 3.6 V, VSS = AVSS = 0 V)

(TA = +85 to +105°C, 2.4 V ≤ AVDD = VDD ≤ 3.6 V, VSS = AVSS = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
How long from when an external reset ends until the initial communication settings are specified <i>Note 1</i>	tsuINIT	POR and LVD reset must end before the external reset ends.			100	ms
How long from when the TOOL0 pin is placed at the low level until an external reset ends <i>Note 1</i>	tsu	POR and LVD reset must end before the external reset ends.	10			μs
How long the TOOL0 pin must be kept at the low level after an external reset ends (excluding the processing time of the firmware to control the flash memory) <i>Notes 1, 2</i>	tHD	POR and LVD reset must end before the external reset ends.	1			ms

**Note 1.** Deassertion of the POR and LVD reset signals must precede deassertion of the pin reset signal.

**Note 2.** This excludes the flash firmware processing time (723 μs).



<1> The low level is input to the TOOL0 pin.

<2> The external reset ends (POR and LVD reset must end before the external reset ends).

<3> The TOOL0 pin is set to the high level.

<4> Setting of the flash memory programming mode by UART reception and complete the baud rate setting.

**Remark** tsuINIT: The segment shows that it is necessary to finish specifying the initial communication settings within 100 ms from when the external resets end.

tsu: How long from when the TOOL0 pin is placed at the low level until a pin reset ends

tHD: How long to keep the TOOL0 pin at the low level from when the external resets end (excluding the processing time of the firmware to control the flash memory)

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